GKS-075 214 100 A 1500

Item GKS-075-0058

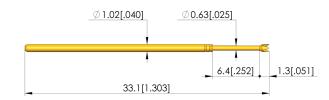




- Well-established test probes for contacting PCBs
- For optimal contact to the test points (e.g. pads, vias, and pins), various tip styles with various diameters and finishes are available.
- · Various spring forces available as well as versions with stainless steel springs suitable for high temperatures
- Used for setting the optimum stroke conditions in the test fixture, various installation heights can be achieved by combining test probes and receptacles









General data

Product group: ICT / FCT (in-circuit test and function test Sub-product group: Standard stroke test probe Series: GKS-075 Grid: 1.91 mm [75.1 mil] Contacting from: Pad Magnetic: Yes Installation type: Plug-in Quick-exchange system: Yes Adjustable installation height: No Non-rotating: No Compatible receptacle(s): KS-075 Min. temperature: -40 °C [-40 °F] Max. temperature: 80 °C [176 °F] RoHS-compliant:

Tip style data

Tip style: 14 4-point crown, self-cleaning Tip diameter: 1 mm [.039 in] Tip style surface: A gold Tip style material: 2 steel

Electrical data

Current load capacity / rated current: 3 A 20 mOhm Typical resistance (Ri):

Mechanical data

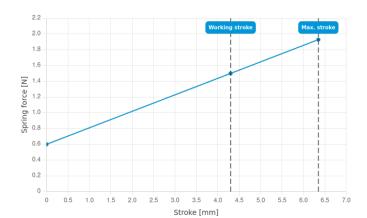
33.1 mm [1.3 in] Total length: Barrel diameter: 1.02 mm [.04 in] Maximum stroke: 6.35 mm [.25 in] Spring pre-load: 0.6 N [2.15 ozf] Collar height: Spring force at working stroke: 1.5 N [5.39 ozf] Recommended working stroke: 4.3 mm [.169 in]

Partner for Future Technology

Test Probe GKS-075 214 100 A 1500

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INGUN Prüfmittelbau GmbH

Max-Stromeyer-Straße 162 78467, Constance, Germany Phone +49 7531 8105-0 Customer hotline +49 7531 8105-888 Fax +49 7531 8105-65 info@ingun.com









Learn more about **ICT/FCT Test probes**

